

Notice of References Cited	Application/Control No. 09/785,416	Applicant(s)/Patent Under Reexamination TANAHASHI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0012816A1	01-2002	Shimizu et al.	428/694TM
	B	US-6221508B1	04-2001	Kanbe et al.	428/617
	C	US-5851643	12-1998	Honda et al.	428/212
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP11-306532	05-1999	Japan	Kanbe et al.	-----
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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